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CALIBRATION PROCEDURE NI PXI/PCI-5922

Flexible-resolution Oscilloscope

This document contains instructions for writing an external calibration procedure for the NI PXI/PCI-5922 (NI 5922) flexible-resolution oscilloscope. This calibration procedure is intended for metrology labs. For more information about calibration solutions, visit ni.com/calibration.

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Introduction

The NI 5922 supports two types of calibration: self-calibration (or internal calibration) and external calibration.

Self-Calibration

Self-calibration, also known as internal calibration, uses a software command and requires no external connections. Self-calibration improves measurement accuracy by compensating for variables such as temperature that may have changed since the last external calibration. Self-calibration retains the traceability of the external calibration.

External Calibration

External calibration is generally performed with a high-precision oscilloscope calibrator at either NI or a metrology lab. The external calibration procedure replaces all calibration constants in the EEPROM and is equivalent to a factory calibration at NI. Because the external calibration procedure changes all EEPROM constants, it invalidates the original calibration certificate. If an external calibration is done with a traceable signal generator source, a new calibration certificate can be issued.

Calibration Intervals

Self-calibration can be performed as necessary to compensate for environmental changes.

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Caution Although you can use self-calibration repeatedly, self-calibrating the NI 5922 more than a few times a day may cause excessive wear on the relays over time.

The measurement accuracy requirements of your application determine how often you should externally calibrate the NI 5922. NI recommends that you perform a complete external calibration at least once every two years. You can shorten this interval based on the accuracy demands of your application or the requirements of your processes. Refer to the *External Calibration Options* section for more information.

Software and Documentation

Calibrating the NI 5922 requires installing NI-SCOPE version 2.8 or later on the calibration system. You can download NI-SCOPE from ni.com/downloads. NI-SCOPE supports programming the self-calibration procedures in a number of programming languages. However, only LabVIEW and C are supported for the external calibration procedures.

NI-SCOPE 2.8 or later includes all the functions and attributes necessary for calibrating the NI 5922. For LabWindowsTM/CVITM, the NI-SCOPE function panel, niScopeCalfp, provides further help on the functions available in CVI. LabVIEW support is installed in niScopeCal.llb, and all calibration functions appear in the function palette. Refer to Table 1 for file locations.

Calibration functions are C function calls or LabVIEW VIs in NI-SCOPE. In this document, the C function call is shown first, followed by the corresponding LabVIEW VI in parentheses. The C function calls are valid for any compiler capable of calling a 32-bit DLL. Many of the functions use constants defined in the niScopeCal.h file. To use these constants in C, you must include niScopeCal.h in your code when you write the calibration procedure.

For more information on the calibration functions and VIs, refer to the *NI-SCOPE Function Reference Help* or the *NI-SCOPE VI Reference Help*. These references can be found in the *NI High-Speed Digitizers Help*. To access this help file, go to **Start>Programs>National Instruments> NI-SCOPE>Documentation>NI High-Speed Digitizers Help**.

File Name and Location	Description
IVI\Bin\niscope_32.dll	NI-SCOPE driver containing the entire NI-SCOPE API, including calibration functions
IVI\Lib\msc\niscope.lib	NI-SCOPE library for Microsoft C containing the entire NI-SCOPE API, including calibration functions
LabVIEW (<i>version</i>)\examples\instr\ niScope	Directory of LabVIEW NI-SCOPE example VIs, including self-calibration; access the calibration example from the LabVIEW function palette
LabVIEW (<i>version</i>)\instr.lib\niScope Calibrate\niScopeCal.llb	LabVIEW VI library containing VIs for calling the NI-SCOPE calibration API; access calibration functions from the NI-SCOPE calibration section of the LabVIEW function palette
IVI\Drivers\niScope\ niScopeCal.fp	CVI function panel file that includes external calibration function prototypes and help on using NI-SCOPE in the CVI environment
IVI\Include\niScopeCal.h	Calibration header file, which you must include in any C program accessing calibration functions. This file automatically includes niScope.h, which defines the rest of the NI-SCOPE interface
IVI\Drivers\niScope\Examples	Directory of NI-SCOPE examples for CVI, C, Visual C++, and Visual Basic

Table 1. Calibration File Locations after Installing NI-SCOPE 2.8 or Later

Documentation

Consult the following documents for information about the NI 5922 and your application software. All documents are available on ni.com, and help files install with the software.



NI PXI/PCI-5922 Getting Started Guide

Contains: NI-SCOPE installation, hardware installation, and hardware programing instructions



NI PXI/PCI-5922 Specifications

Contains: NI 5922 specifications and calibration intervals



NI-SCOPE Readme

Contains: Operating system and application software support in NI-SCOPE



NI High Speed Digitizers Help

Contains: Detailed information about NI PXI/PCI-5922

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NI-SCOPE LabVIEW Reference Help

Contains: LabVIEW programming concepts and reference information about NI-SCOPE VIs and functions



NI-SCOPE Function Reference Help

Contains: Reference information for NI-SCOPE C functions and NI-SCOPE C properties

Self-Calibration Procedures

The NI 5922 includes precise internal circuits and references used during self-calibration to adjust for time and temperature drift. The oscilloscope gain, offset, and flatness are all corrected in self-calibration. Measuring the accuracy of these internal calibration circuits with another instrument during external calibration provides traceability for the verification procedure. Absolute accuracy is ensured by compensating for any error measured in the internal references.



Note Self-calibrate the oscilloscope before you perform verification. NI-SCOPE includes self-calibration example programs for LabVIEW, CVI, and Microsoft Visual C.

You can initiate self-calibration using Measurement & Automation Explorer (MAX), using the Scope Soft Front Panel (SFP), or programmatically using NI-SCOPE.

MAX

To initiate self-calibration from MAX, complete the following steps:

- 1. Disconnect or disable any AC inputs to the oscilloscope.
- 2. Launch MAX.
- 3. Select My System»Devices and Interfaces.
- 4. Select the device that you want to calibrate.
- 5. Initiate self-calibration using one of the following methods:
 - Click **Self-Calibrate** in the upper right corner of MAX.
 - Right-click the name of the device in the MAX configuration tree and select **Self-Calibrate** from the drop-down menu.

Scope SFP

To initiate self-calibration from the Scope SFP, complete the following steps:

- 1. Disconnect or disable any AC inputs to the oscilloscope.
- 2. Launch the Scope SFP by selecting Start»Programs»National Instruments» NI-SCOPE»Scope Soft Front Panel.
- 3. Select the device you want to calibrate using the Select Device dialog box or by selecting **Edit**»Change Device.
- 4. Launch the Calibration dialog box by selecting Utility»Self Calibration.
- 5. Click **OK** to begin self-calibration.

NI-SCOPE

To self-calibrate the NI 5922 programmatically using NI-SCOPE, complete the following steps:

- 1. Disconnect or disable any AC inputs to the oscilloscope.
- 2. Call niScope_init (niScope Initialize VI) to obtain an instrument session handle. Set the following parameters:
 - resourceName: The device name assigned by MAX
 - IDQuery: NISCOPE VAL VI FALSE
 - resetDevice: NISCOPE_VAL_VI_FALSE
 - vi: The returned session handle that you use to identify the instrument in all subsequent instrument driver function calls

- 3. Call niScope_CalSelfCalibrate (niScope Cal Self Calibrate VI) with the following parameters:
 - sessionHandle: The instrument handle that you obtain from niScope_init (niScope Initialize VI)
 - channelList: VI_NULL
 - option: VI_NULL

Because the session is a standard session rather than an external calibration session, the new calibration constants are immediately stored in the EEPROM. Therefore, you can include this procedure in any application that uses the oscilloscope.

- 4. Call niScope_close (niScope Close VI) to close the session handle. Set the following parameter:
 - vi: The instrument handle you obtained from niScope_init

External Calibration Options

External calibration involves both adjustment and verification. Adjustment is the process of measuring and compensating for device performance to improve the measurement accuracy. Performing an adjustment updates the calibration date, effectively resetting the calibration interval. The device is guaranteed to meet or exceed its published specifications for the duration of the calibration interval. Verification is the process of testing the device to ensure that the measurement accuracy is within certain specifications. Verification can be used to ensure that the adjustment process was successful or to determine if the adjustment process must be performed. During verification, you must compare the measurement error to limits given in Tables 3 through 7.

This document provides two sets of test limits for most verification stages—the *calibration test limits* and the *published specifications*. The calibration test limits are more restrictive than the published specifications. If all of the measurement errors determined during verification fall within the calibration test limits, the device is guaranteed to meet or exceed its published specifications for a full calibration interval (two years). For this reason, you must verify against the calibration test limits when performing verification after adjustment. If all of the measurement errors determined during verifications, but not within the calibration test limits, the device is meeting its published specifications. However, the device will not necessarily remain within these specifications for an additional two years. The device will meet published specifications for the remainder of the current calibration interval. In this case, you can perform an adjustment if you want to further improve the measurement accuracy or reset the calibration interval. If some measurement errors determined during verifications, you must perform an adjustment to restore the device operation to its published specifications.

The *Complete Calibration* section describes the recommended calibration procedure. The *Optional Calibration* section describes alternative procedures that allow you to skip adjustment if the device already meets its calibration test limits or published specifications.

Complete Calibration

Performing a complete calibration is the recommended way to guarantee that the NI 5922 meets or exceeds its published specifications for a two-year calibration interval. At the end of the complete calibration procedure, you verify that the measurement error falls within the calibration test limits. Figure 1 shows the programming flow for complete calibration.

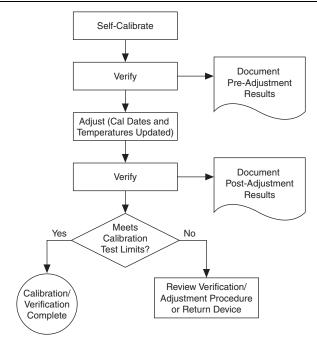


Figure 1. Complete Calibration Programming Flow

Optional Calibration

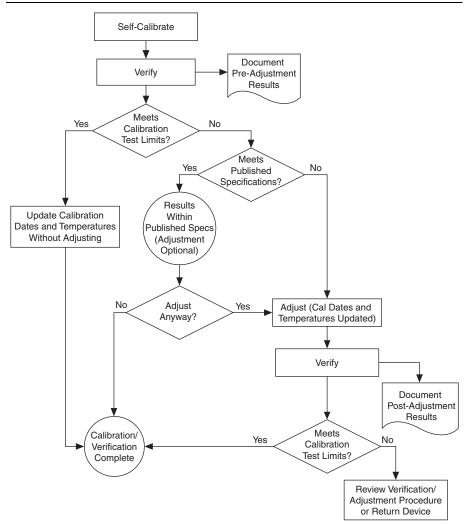
You can choose to skip the adjustment steps of the calibration procedure if the measurement error is within the calibration test limits or the published specifications during the first verification. If all of the measurement errors determined during the first verification fall within the calibration test limits, the device is guaranteed to meet or exceed its published specifications for a full calibration interval. In this case, you can update the calibration date, effectively resetting the calibration interval, without actually performing an adjustment. Refer to the *Adjusting the NI 5922* section for more information.

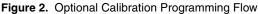
If all of the measurement errors determined during the first verification fall within the published specifications, but not within the calibration test limits, adjustment is also optional. However, you cannot update the calibration date because the device will not necessarily operate within the published specifications for an additional two years.



Note Regardless of the results of the first verification, if you perform an adjustment, you must verify that the measurement error falls within the calibration test limits at the end of the calibration procedure.

Figure 2 shows the programming flow for the optional calibration.





Test Equipment

Table 2 lists the equipment required for externally calibrating the NI 5922. If you do not have the recommended instruments, use these specifications to select a substitute calibration standard.

Required Equipment	Recommended Equipment	Parameter Measured	Specification
Signal Generator	Fluke 9500B oscilloscope calibrator	Timing	2 ppm frequency accuracy
	9510 Test Head (or Wavetek 9500 with high-stability reference option)		
DC Source	Fluke 5700	Vertical Gain	DC ± 50 ppm into 1 M Ω
BNC cable			50 Ω

Table 2. Required Equipment for NI 5922 External Calibration



Note The delay times indicated in this procedure apply specifically to the Fluke 9500B calibrator. If you use a different calibrator, you may need to increase these delay times. This increase varies between calibrator models.

Test Conditions

Follow these guidelines to optimize the connections and the environment during calibration:

- Always connect the scope calibrator to the input BNC of the oscilloscope, or use a short 50 Ω BNC coaxial cable if necessary. Long cables and wires act as antennas, picking up extra noise that can affect measurements.
- Keep relative humidity between 10 and 90%, non-condensing.
- Maintain an ambient temperature of 23 ± 5 °C.
- Allow a warm-up time of at least 15 minutes after NI-SCOPE loads. Unless manually disabled, NI-SCOPE automatically loads with the operating system and enables the device. The warm-up time ensures that the measurement circuitry of the NI 5922 is at a stable operating temperature.
- Ensure that the PXI chassis fan speed is set to HI, that the fan filters are clean, and that the empty slots contain filler panels.
- Plug the PXI chassis or PC and the calibrator into the same power strip to avoid ground loops.

External Calibration Procedures

The complete external calibration procedure consists of self-calibrating, verifying the performance of the oscilloscope, adjusting the calibration constants, and verifying again after the adjustments. In some cases, the complete calibration procedure may not be required. Refer to the *External Calibration Options* section for more information.

The external calibration procedure automatically stores the calibration date to allow traceability.

Verifying NI 5922 Specifications



Note After the 15-minute warm-up time, always self-calibrate the NI 5922 before beginning a verification procedure.

This section describes the program you must write to verify either the calibration test limits or the published specifications for the NI 5922. Refer to the *External Calibration Options* section to determine which limits to use in these procedures.

All verification procedures described in this section begin with <code>niScope_init</code> (niScope Initialize VI) with resetDevice set to <code>NISCOPE_VAL_TRUE</code> and end with <code>niScope_close</code> (niScope Close VI).

If any of these tests fail immediately after you perform an external adjustment, verify that you have met the required test conditions listed in the *External Calibration Requirements* section before you return the oscilloscope to NI for repair.

Vertical Offset Accuracy

Complete the following steps to verify vertical offset accuracy of the NI 5922. You must verify both channels and each iteration listed in Table 3.

- 1. Disconnect all cabling from the BNC inputs of the NI 5922. No input signal is needed because the NI 5922 internal 50 Ω resistor connects the input to ground.
- 2. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_50_OHM
 - maxInputFrequency: 0
- 3. Call niScope_ConfigureVertical (niScope Configure Vertical VI) with the following parameters:
 - channelList: "0"
 - range: The *Range* value for the current iteration from Table 3
 - offset: 0.0
 - **coupling**: NISCOPE_VAL_DC
 - probeAttenuation: 1.0
 - enabled: NISCOPE_VAL_TRUE

- 4. Call niScope_ConfigureHorizontalTiming (niScope Configure Horizontal Timing VI) with the following parameters:
 - minSampleRate: 10,000,000
 - minNumPts: 100,000
 - refPosition: 50.0
 - numRecords: 1
 - enforceRealtime: NISCOPE_VAL_TRUE
- 5. Call niScope_InitiateAcquisition. (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 6. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_VOLTAGE_AVERAGE

Compare the resulting average voltage to the value listed in the *Calibration Test Limits* column or the *Published Specifications* column in Table 3 that corresponds to the vertical range used. If the result is within the selected test limit, the device has passed this portion of the verification.

- 7. Repeat steps 1 through 6 for each iteration in Table 3.
- 8. Repeat steps 1 through 7 for channel 1, changing the value of the **channelList** parameter from "0" to "1".

Iteration	Range (V)	Calibration Test Limits (V)	Published Specifications (V)
1	2	±26 µV	$\pm 50 \ \mu V$
2	10	$\pm 48 \ \mu V$	$\pm 100 \ \mu V$

Table 3. NI 5922 Vertical Offset Calibration

Noise

Complete the following steps to verify noise performance of the NI 5922. You must verify both channels and each iteration listed in Table 4.

- 1. Disconnect all cabling from the BNC inputs of the NI 5922. No input signal is needed because the NI 5922 internal 50 Ω resistor connects the input to ground.
- 2. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_50_OHM
 - maxInputFrequency: 0

- 3. Call niScope_ConfigureVertical (niScope Configure Vertical VI) with the following parameters:
 - channelList: "0"
 - Range: The Range value for the current iteration from Table 4
 - **Offset**: 0.0
 - Coupling: NISCOPE VAL DC
 - **ProbeAttenuation**: 1.0
 - **Enabled**: NISCOPE_VAL_TRUE
- 4. Call niScope_ConfigureHorizontalTiming (niScope Configure Horizontal Timing VI) with the following parameters:
 - minSampleRate: The Sample Rate value for the current iteration
 - minNumPts: 65536
 - refPosition: 50.0
 - numRecords: 1
 - enforceRealtime: NISCOPE_VAL_TRUE
- 5. Call niScope_InitiateAcquisition (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 6. Call niScope_FetchArrayMeasurement (niScope Fetch Array Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 5.0
 - arrayMeasFunction: NISCOPE_VAL_FFT_AMP_SPECTRUM_VOLTS_RMS
 - measWfmSize: -1
- 7. Calculate the noise value from the returned voltage array V[n] using the following formula:

Noise RMS =
$$\sqrt{\sum_{n=i}^{26215} (V[n])^2}$$

where *i* is obtained from Table 4.

- a. Add up the squares of each element in the returned array starting with element i and ending with element 26,215. The first element in the array is element 0.
- b. Take the square root of the resulting sum. The result is the RMS noise between 100 Hz and $0.4 \times Sample Rate$.

Compare the result from this step to the value listed in the *Published Specifications* column in Table 4.

8. Repeat steps 1 through 7 for each iteration in Table 4.

9. Repeat steps 1 through 8 for channel 1, changing the value of the **channelList** parameter from "0" to "1".

Iteration	Range (V)	Sample Rate (S/s)	i	Calibration Test Limits	Published Specifications
1	2	50 k	132	0.95 µV	1 µV
2	2	100 k	66	1.12 μV	1.2 μV
3	2	1 M	7	4.05 μV	4.2 μV
4	2	5 M	2	8.5 μV	8.7 μV
5	2	10 M	1	19.1 µV	20 µV
6	2	15 M	1	77 µV	80 µV
7	10	50 k	132	3.23 μV	3.4 µV
8	10	100 k	66	4.11 μV	4.3 μV
9	10	1 M	7	12.7 μV	13 µV
10	10	5 M	2	29.5 μV	31 µV
11	10	10 M	1	88 µV	92 μV
12	10	15 M	1	384 µV	401 µV

Table 4. NI 5922 Noise Performance

Input Bias Current

Complete the following steps to verify input bias current of the NI 5922. You must verify both channels.

- 1. Disconnect all cabling from the BNC inputs of the NI 5922.
- 2. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_50_OHM
 - maxInputFrequency: 0
- 3. Call niScope_ConfigureVertical (niScope Configure Vertical VI) with the following parameters:
 - channelList: "0"
 - range: 2
 - offset: 0.0
 - coupling: NISCOPE_VAL_DC
 - probeAttenuation: 1.0
 - enabled: NISCOPE_VAL_TRUE

- 4. Call niScope_ConfigureHorizontalTiming (niScope Configure Horizontal Timing VI) with the following parameters:
 - minSampleRate: 1,000,000
 - minNumPts: 100,000
 - refPosition: 50.0
 - numRecords: 1
 - enforceRealtime: NISCOPE_VAL_TRUE
- 5. Call niScope_InitiateAcquisition. (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 6. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_DC_ESTIMATE
- 7. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_1_MEG_OHM
 - maxInputFrequency: 0
- 8. Call niScope_InitiateAcquisition (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 9. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_DC_ESTIMATE
- 10. Calculate the bias current using the following formula:

$$Bias \ Current = \frac{a-b}{1,000,000}$$

where a = the voltage measured in step 6

b = the voltage measured in step 9

1,000,000 is the NI 5922 impedance in ohms

Compare the resulting bias current to the value listed in the *Calibration Test Limits* column or the *Published Specifications* column in Table 5. If the result is less than the selected test limit, the device has passed this portion of the verification.

11. Repeat steps 1 through 10 for channel 1, changing the value of the **channelList** parameter from "0" to "1".

Calibration Test Limit	Published Specification
±350 nA	±500 nA

Vertical Gain Accuracy

Complete the following steps to verify vertical gain accuracy of the NI 5922. You must verify both channels and each iteration listed in Table 6.

- 1. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_1_MEG_OHM
 - maxInputFrequency: 0
- 2. Call niScope_ConfigureVertical (niScope Configure Vertical VI) with the following parameters:
 - channelList: "0"
 - range: The *Range* value for the current iteration from Table 6
 - offset: 0.0
 - coupling: NISCOPE VAL DC
 - probeAttenuation: 1.0
 - enabled: NISCOPE_VAL_TRUE
- 3. Call niScope_ConfigureHorizontalTiming (niScope Configure Horizontal Timing VI) with the following parameters:
 - minSampleRate: 10,000,000
 - minNumPts: 100,000
 - refPosition: 50.0
 - numRecords: 1
 - enforceRealtime: NISCOPE_VAL_TRUE
- 4. Call niScope Commit (niScope Commit VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 5. Connect the DC voltage calibrator source to the channel 0 input of the oscilloscope and output the positive voltage from Table 6 that corresponds to the vertical range used.
- 6. Wait 2,500 ms for the calibrator to settle.
- 7. Call niScope_InitiateAcquisition (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope init

- 8. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_VOLTAGE_AVERAGE
- 9. Generate the negative voltage listed in Table 6 with the calibrator.
- 10. Wait 2,500 ms for the output of the calibrator to settle.
- 11. Call niScope_InitiateAcquisition (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 12. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_VOLTAGE_AVERAGE
- 13. Calculate the error in the vertical gain as a percentage of input using the following formula:

$$error = \left(\frac{a-b}{c-d}\right) - 1 \times 100$$

where a = the measured positive voltage

b = the measured negative voltage

c = the applied positive voltage

d = the applied negative voltage

Compare the resulting percent error to the *Calibration Test Limits* or the *Published Specifications* listed in Table 6. If the result is within the selected test limit, the device has passed this portion of the verification.

- 14. Repeat steps 1 through 13 for each iteration listed in Table 6, changing the *Range*, *Positive Input*, and *Negative Input* values accordingly.
- 15. Move the calibrator to the oscilloscope input channel 1 and repeat steps 1 through 14, changing the value of the **channelList** parameter from "0" to "1".

Iteration	Range (V)	Positive Input (V)	Negative Input (V)	Calibration Test Limits	Published Specifications
1	2	0.9	-0.9	±0.0293%	±0.05%
2	10	4.5	-4.5	±0.0293%	±0.05%

Table 6. NI 5922 Vertical Gain Stimuli

Timing Accuracy

Complete the following steps to verify the timing accuracy for the NI 5922.



Note The same time source is used for both channel 0 and channel 1, so you only need to verify the timing accuracy on one channel.

- 1. Call niScope_ConfigureChanCharacteristics (niScope Configure Chan Characteristics VI) with the following parameters:
 - channelList: "0"
 - inputImpedance: NISCOPE_VAL_50_OHM
 - maxInputFrequency: 0
- 2. Call niScope_ConfigureVertical (niScope Configure Vertical VI) with the following parameters:
 - channelList: "0"
 - range: 10
 - offset: 0.0
 - coupling: NISCOPE_VAL_DC
 - probeAttenuation: 1.0
 - enabled: NISCOPE_VAL_TRUE
- 3. Call niScope_ConfigureHorizontalTiming (niScope Configure Horizontal Timing VI) with the following parameters:
 - minSampleRate: 15,000,000
 - minNumPts: 1,000,000
 - refPosition: 50.0
 - numRecords: 1
 - enforceRealtime: NISCOPE_VAL_TRUE
- 4. Call niScope _Commit (niScope Commit VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 5. Connect the scope calibrator to the channel 0 input of the oscilloscope. Configure the calibrator to output an exact 2 MHz sine wave with 1 V peak-to-peak amplitude and 50 Ω load impedance.
- 6. Wait 1,000 ms for the impedance matching and frequency of the calibrator to settle.
- 7. Call niScope_InitiateAcquisition (niScope Initiate Acquisition VI) with the following parameter:
 - vi: The instrument handle you obtained from niScope_init
- 8. Call niScope_FetchMeasurement (niScope Fetch Measurement VI) with the following parameters:
 - channelList: "0"
 - **timeout**: 1.0
 - scalarMeasFunction: NISCOPE_VAL_FFT_FREQUENCY

9. Calculate the error in timing as parts per million (ppm) using the following formula:

$$error = \frac{(a-2,000,000)}{2}$$

where a = the measured frequency

Compare the result to the *Calibration Test Limits* or the *Published Specifications* listed in Table 7. If the result is within the selected test limit, the device has passed this portion of the verification.

Table 7. NI 5922 Timing Accuracy

Calibration Test Limit	Published Specification
±5.3 ppm	±50 ppm

Adjusting the NI 5922

If the NI 5922 successfully passed each of the verification procedures within the calibration test limits, then an adjustment is recommended but not required to guarantee its published specifications for the next two years. If the oscilloscope was not within the calibration test limits for each of the verification procedures, you can perform the adjustment procedure to improve the accuracy of the oscilloscope. Refer to the *External Calibration Options* section to determine which procedures to perform.

An adjustment is required only once every two years. Following the adjustment procedure automatically updates the calibration date and temperature in the EEPROM of the oscilloscope.



Note If the oscilloscope passed the entire verification procedure within the calibration test limits and you do not want to perform an adjustment, you can update the calibration date and onboard calibration temperature without making any adjustments by completing *only* steps 4 and 13 in this section.

Complete all of the following steps to externally adjust the NI 5922.

- 1. Connect the scope calibrator to the channel 0 input of the oscilloscope. Configure the calibrator to output an exact 1 MHz sine wave with 1 V peak-to-peak amplitude and 1 M Ω load impedance.
- 2. Connect the DC source calibrator to the channel 1 input of the oscilloscope. Configure the DC source calibrator to output an exact 4 V DC signal into a 1 M Ω load impedance (channel 1).
- 3. Wait 3,000 ms for the calibrator to settle.
- 4. Call niScope_CalStart (niScope Cal Start VI) using the user password. The factory default password for the NI 5922 is NI.
- 5. Call niScope_CalSelfCalibrate (niScope Cal Self Calibrate VI) with the following parameters:
 - channelList: VI_NULL
 - option: VI_NULL

- 6. Call niScope_CalAdjustVCXO (niScope Cal Adjust VCXO VI) with the following parameter:
 - **stimulusFreq**: 1,000,000



Note The 1 MHz stimulus is automatically taken from channel 0.

- 7. Call niScope_CalAdjustRange (niScope Cal Adjust Range VI) with the following parameters:
 - channelName: "1"
 - range: 0
 - **stimulus**: 4.0
- 8. Configure the DC source calibrator to output an exact -4 V DC signal into a 1 M Ω load impedance (channel 1).
- 9. Wait 3,000 ms for the calibrator to settle.
- 10. Call niScope_CalAdjustRange (niScope Cal Adjust Range VI) with the following parameters:
 - channelName: "1"
 - range: 0
 - **stimulus**: -4.0
- 11. Disconnect or disable all inputs to the oscilloscope.
- 12. Call niScope_CalSelfCalibrate (niScope Cal Self Calibrate VI) with the following parameters:
 - channelList: VI_NULL
 - option: VI_NULL
- 13. Call niScope_CalEnd with the following parameters:
 - sessionHandle: The instrument handle you obtained from niScope_CalStart
 - action: NISCOPE_VAL_ACTION_STORE to save the results of the calibration

You have finished adjusting the NI 5922. It is not necessary to adjust each channel individually. However, you should repeat the entire verification procedure to verify a successful adjustment.

Calibration Utilities

NI-SCOPE supports several calibration utilities that allow you to retrieve information about adjustments performed on the NI 5922, change the external calibration password, and store small amounts of information in the onboard EEPROM. You can retrieve some data using MAX; however, you can retrieve all the data programmatically using NI-SCOPE functions.

MAX

To retrieve data using MAX, complete the following steps:

- 1. Select the device from which you want to retrieve information from My System»Devices and Interfaces.
- 2. Select the Calibration tab.

You should see information about the last date and temperature for both external and self-calibration.

NI-SCOPE

NI-SCOPE provides a full complement of calibration utility functions and VIs. Refer to the *NI High-Speed Digitizers Help* for the complete function reference and VI reference for the following utility functions:

- niScope_CalChangePassword (niScope Cal Change Password VI)
- niScope_CalFetchCount (niScope Cal Fetch Count VI)
- niScope CalFetchDate (niScope Cal Fetch Date VI)
- niScope CalFetchMiscInfo (niScope Cal Fetch Misc Info VI)
- niScope CalFetchTemperature (niScope Cal Fetch Temperature VI)
- niScope CalStoreMiscInfo (niScope Cal Store Misc Info VI)

Where to Go for Support

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